

FORM-PTO 1A49 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

Date Submitted to PTO: March 24, 2004

ATTY DOCKET NO.
2004_0449SERIAL NO.
NEW

10/807,389

APPLICANT
Shigeru FURUMIYA et al.FILING DATE
March 23, 2004

GROUP

2655

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>ch</i>	AA	6,160,776	12/2000	Seo			
<i>ch</i>	AB	4,825,403	4/1989	Gershenson et al.			
<i>ch</i>	AC	5,835,461	11/1998	Kobayashi et al.			
<i>ch</i>	AD	6,122,233	9/2000	Iketani et al.			
<i>ch</i>	AE	5,850,382	12/1998	Koishi et al.			
<i>ch</i>	AF	6,400,653	6/2002	Torazawa et al.			
	AG						
	AH						
	AI						
	AJ						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
<i>ch</i>	AK	8-315426	11/1996	JP			Abstr.	
<i>ch</i>	AL	11-273090	10/1999	JP			Abstr.	
<i>ch</i>	AM	11-288518	10/1999	JP			Abstr.	
<i>ch</i>	AN	11-273090	10/1999	JP			Abstr.	
<i>ch</i>	AO	11-273089	10/1999	JP			Abstr.	

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	AP	
	AQ	

EXAMINER

Muhammad Edun

DATE CONSIDERED

8/22/05

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<i>ce</i>	AG	2000-149271	5/2000	JP			Abstr.
<i>ce</i>	AH	1 001 409	5/2000	EP			
<i>ce</i>	AI	0 751 508	1/1997	EP			
<i>ce</i>	AJ	0 930 611	7/1999	EP			
<i>ce</i>	AK	11-25492	1/1999	JP			Abstr.
<i>ce</i>	AL	98/10415	3/1998	WO			
<i>ce</i>	AM	2000-235713	8/2000	JP			Abstr.

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	AN	
	AO	
	AP	
EXAMINER	Muhammad Edun Primary Examiner	
	DATE CONSIDERED	8/22/05

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FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
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Date Submitted to PTO: July 29, 2004

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Shigeru FURUMIYA et al.FILING DATE
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U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
	AJ	0 177 311	04/1986	Europe				
	AK	WO 98/50914	11/1998	WIPO				
	AL							
	AM							
	AN							

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

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	AP	
	AQ	

EXAMINER

Muhammad Edun
Primary Examiner

DATE CONSIDERED

8/22/05

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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
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Date Submitted to PTO: May 14, 2004





MAY 14 2004

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2004-0449SERIAL NO.
10/807,389APPLICANT
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March 23, 2004


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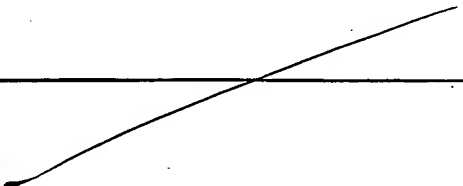
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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	6,377,537 B1	4/2002	Maeda et al.	 	 	
	AB	6,671,238 B1	12/2003	Ko et al.	 	 	
	AC	5,831,951	11/1998	Kamioka et al.	 	 	
	AD	6,259,658	7/2001	Tanoue et al.	 	 	
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO	
	AJ	9-282667A	10/1997	JP	 	 	Abstract	
	AK							
	AL							
	AM							
	AN							

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER	Muhammad Edun Primary Examiner	
	DATE CONSIDERED	8/22/05